

Search Notes

Application No.

10/065,552

Applicant(s)

SAWADA ET AL.

Examiner

Wai-Sing Louie.

Art Unit

2814

SEARCHED

Class	Subclass	Date	Examiner
438	14-18	11/15/2004	WSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
wafer charge measurement, liquid electrode, capacitance/voltage, C/V technique, carrier density, gallium	11/15/2004	WSL